

Photocouplers Photorelay

# TLP4176A

#### 1. Applications

- High-Speed Memory Testers
- High-Speed Logic IC Testers
- Factory Automation (FA)
- Power supplies
- Mechanical relay replacements

#### 2. General

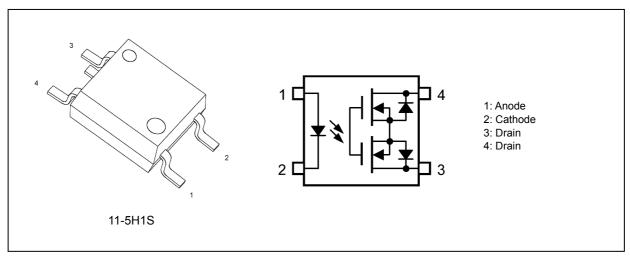
The TLP4176A photorelay consists of a photo MOSFET optically coupled to an infrared light emitting diode. It is housed in a 4 pin package with 2.54 mm lead pitch and 2.1 mm height.

 $The \,TLP4176 A \, is \, suitable \, for \, replacement \, of \, mechanical \, relays \, in \, many \, applications \, which \, require \, space \, savings.$ 

### 3. Features

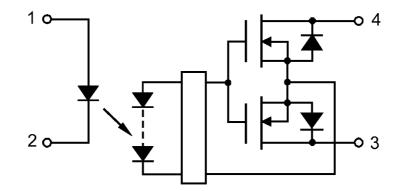
- (1) Package: SOP (2.54SOP4) (Height 2.1 mm, Pitch 2.54 mm)
- (2) Normally closed (1-Form-B)
- (3) OFF-state output terminal voltage: 60 V (min)
- (4) Trigger LED current: 3 mA (max)
- (5) ON-state current: 500 mA (max) ( $T_a = 25 \text{ °C}$ )
- (6) ON-state resistance:  $2.5 \Omega$  (max)
- (7) Isolation voltage: 1500 Vrms (min)
- (8) Safety standardsUL-recognized: UL 1577, File No.E67349

### 4. Packaging and Pin Assignment



Rev.3.0

## 5. Internal Circuit



## 6. Absolute Maximum Ratings (Note) (Unless otherwise specified, $T_a = 25$ °C)

	Characteristics		Symbol	Note	Rating	Unit
LED	Input forward current		I <sub>F</sub>		50	mA
	Input forward current derating	$(T_a \ge 25 \ ^\circ C)$	$\Delta I_F / \Delta T_a$		-0.5	mA/°C
	Input forward current (pulsed) (	100 μs pulse, 100 pps)	I <sub>FP</sub>		1	A
	Input reverse voltage		V <sub>R</sub>		5	V
	Junction temperature		Тj		125	°C
Detector	OFF-state output terminal voltage		V <sub>OFF</sub>		60	V
	ON-state current		I <sub>ON</sub>		500	mA
	ON-state current derating	$(T_a \ge 25 \ ^\circ C)$	$\Delta I_{ON} / \Delta T_a$		-5.0	mA/°C
	Junction temperature		Tj		125	°C
Common	Storage temperature		T <sub>stg</sub>		-55 to 125	°C
	Operating temperature		T <sub>opr</sub>		-40 to 105	°C
	Lead soldering temperature	(10 s)	T <sub>sol</sub>		260	°C
	Isolation voltage (A	AC, 60 s, R.H. ≤ 60 %)	BVS	(Note 1)	1500	Vrms

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: This device is considered as a two-terminal device: Pins 1 and 2 are shorted together, and pins 3 and 4 are shorted together.

## 7. Recommended Operating Conditions (Note)

Characteristics	Symbol	Note	Min	Тур.	Max	Unit
Supply voltage	V <sub>DD</sub>		_	_	48	V
Input forward current	١ <sub>F</sub>		5	—	25	mA
ON-state current	I <sub>ON</sub>		_		500	mA
Operating temperature	T <sub>opr</sub>		-20	_	85	٦°

Note: The recommended operating conditions are given as a design guide necessary to obtain the intended performance of the device. Each parameter is an independent value. When creating a system design using this device, the electrical characteristics specified in this data sheet should also be considered.

## 8. Electrical Characteristics (Unless otherwise specified, $T_a = 25$ °C)

	Characteristics	Symbol	Note	Test Condition	Min	Тур.	Max	Unit
LED	Input forward voltage	V <sub>F</sub>		I <sub>F</sub> = 10 mA	1.0	1.15	1.3	V
	Input reverse current	I <sub>R</sub>		V <sub>R</sub> = 5 V	_		10	μA
	Input capacitance	Ct		V = 0 V, f = 1 MHz	_	30	_	pF
Detector	OFF-state current	I <sub>OFF</sub>		V <sub>OFF</sub> = 60 V, I <sub>F</sub> = 5 mA	_	_	1	μA
	Output capacitance	C <sub>OFF</sub>		V = 0 V, f = 1 MHz, I <sub>F</sub> = 5 mA	_	100	_	pF

## 9. Coupled Electrical Characteristics (Unless otherwise specified, $T_a = 25$ °C)

Characteristics	Symbol	Note Test Condition		Min	Тур.	Max	Unit
Trigger LED current	I <sub>FC</sub>		I <sub>OFF</sub> = 10 μA	_	1	3	mA
Return LED current	I <sub>FT</sub>		I <sub>ON</sub> = 500 mA	0.1	_		mA
ON-state resistance	R <sub>ON</sub>		I <sub>ON</sub> = 500 mA	_	1	2.5	Ω

## 10. Isolation Characteristics (Unless otherwise specified, $T_a = 25$ °C)

Characteristics	Symbol	Note Test Condition		Min	Тур.	Max	Unit
Total capacitance (input to output)	Cs	(Note 1)	V <sub>S</sub> = 0 V, f = 1 MHz	_	0.8	—	pF
Isolation resistance	R <sub>S</sub>	(Note 1)	$V_S$ = 500 V, R.H. $\leq$ 60 %	$5  imes 10^{10}$	1014	—	Ω
Isolation voltage	BVS	(Note 1)	AC, 60 s	1500	_	_	Vrms

Note 1: This device is considered as a two-terminal device: Pins 1 and 2 are shorted together, and pins 3 and 4 are shorted together.

#### 11. Switching Characteristics (Unless otherwise specified, $T_a = 25$ °C)

Characteristics	Symbol	Note	Test Condition	Min	Тур.	Max	Unit
Turn-on time	t <sub>ON</sub>		See Fig. 11.1. $R_L$ = 200 $\Omega$ , $V_{DD}$ = 20 V, $I_F$ = 5 mA	Ι	0.3	1	ms
Turn-off time	t <sub>OFF</sub>		See Fig. 11.1. R <sub>L</sub> = 200 Ω, V <sub>DD</sub> = 20 V, I <sub>F</sub> = 5 mA	_	0.7	3	ms

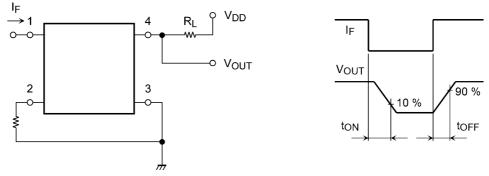
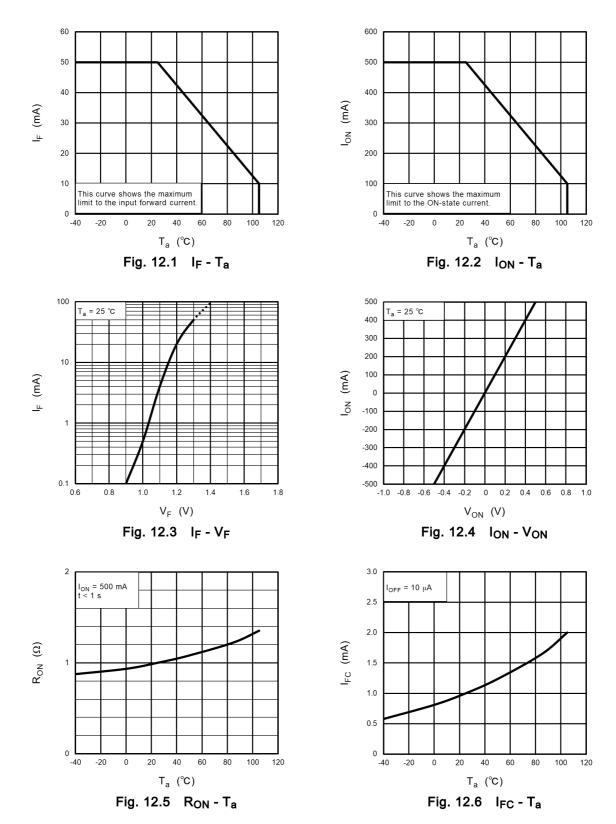
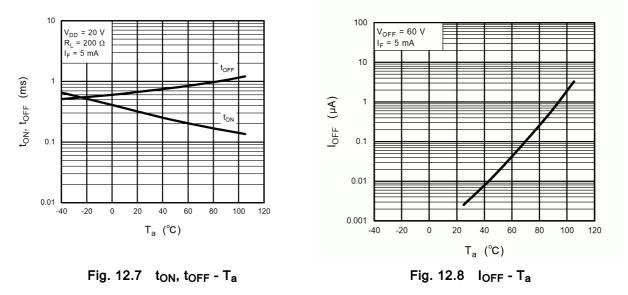


Fig. 11.1 Switching Time Test Circuit and Waveform

## 12. Characteristics Curves (Note)





Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

### 13. Soldering and Storage

#### 13.1. Precautions for Soldering

The soldering temperature should be controlled as closely as possible to the conditions shown below, irrespective of whether a soldering iron or a reflow soldering method is used.

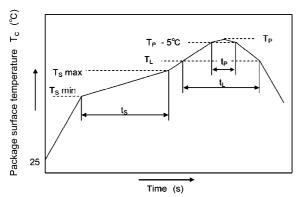
• When using soldering reflow.

The soldering temperature profile is based on the package surface temperature.

(See the figure shown below, which is based on the package surface temperature.)

Reflow soldering must be performed once or twice.

The mounting should be completed with the interval from the first to the last mountings being 2 weeks.



	Symbol	Min	Max	Unit
Preheat temperature	Ts	150	200	°C
Preheat time	t <sub>s</sub>	60	120	s
Ramp-up rate ( $T_L$ to $T_P$ )			3	°C/s
Liquidus temperature	TL	2	17	°C
Time above T <sub>L</sub>	tL	60	150	S
Peak temperature	Τ <sub>Ρ</sub>		260	°C
Time during which $T_c$ is between (T_P – 5) and T_P	t <sub>P</sub>		30	S
Ramp-down rate $(T_P \text{ to } T_L)$			6	°C/s

#### An Example of a Temperature Profile When Lead(Pb)-Free Solder Is Used

• When using soldering flow

Preheat the device at a temperature of 150  $^{\circ}$ C (package surface temperature) for 60 to 120 seconds. Mounting condition of 260  $^{\circ}$ C within 10 seconds is recommended.

Flow soldering must be performed once.

When using soldering Iron

Complete soldering within 10 seconds for lead temperature not exceeding 260 °C or within 3 seconds not exceeding 350 °C

Heating by soldering iron must be done only once per lead.

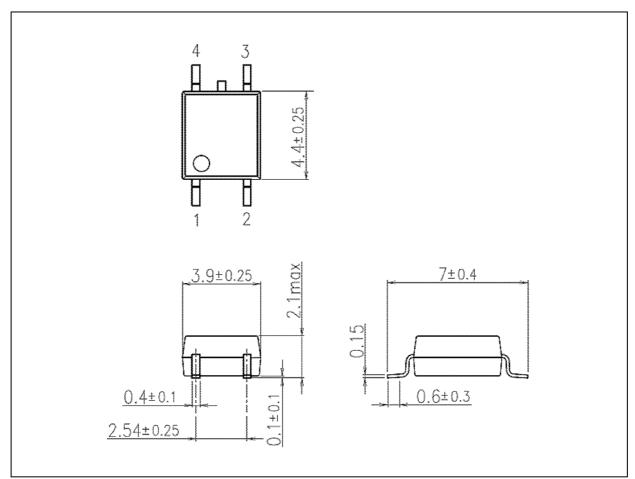
## 13.2. Precautions for General Storage

- Avoid storage locations where devices may be exposed to moisture or direct sunlight.
- Follow the precautions printed on the packing label of the device for transportation and storage.
- Keep the storage location temperature and humidity within a range of 5 °C to 35 °C and 45 % to 75 %, respectively.
- Do not store the products in locations with poisonous gases (especially corrosive gases) or in dusty conditions.
- Store the products in locations with minimal temperature fluctuations. Rapid temperature changes during storage can cause condensation, resulting in lead oxidation or corrosion, which will deteriorate the solderability of the leads.
- When restoring devices after removal from their packing, use anti-static containers.
- Do not allow loads to be applied directly to devices while they are in storage.
- If devices have been stored for more than two years under normal storage conditions, it is recommended that you check the leads for ease of soldering prior to use.

## Package Dimensions

Unit: mm

TLP4176A



Weight: 0.1 g (typ.)

Package Name(s) TOSHIBA: 11-5H1S

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